

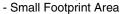
Vishay Siliconix

# **Dual P-Channel 12-V (D-S) MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ $I_{D}(A)$		Q <sub>g</sub> (Typ.)	
	0.070 at V <sub>GS</sub> = - 4.5 V	- 4.5 <sup>a</sup>		
- 12	0.100 at V <sub>GS</sub> = - 2.5 V	- 4.5 <sup>a</sup>	5 nC	
	0.140 at V <sub>GS</sub> = - 1.8 V	- 4.5 <sup>a</sup>		

### **FEATURES**

- · Halogen-free
- TrenchFET® Power MOSFET
- New Thermally Enhanced PowerPAK® SC-70 Package

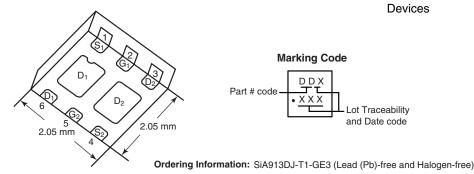


- Low On-Resistance

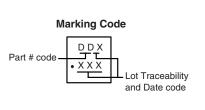


#### **APPLICATIONS**

Load Switch, PA Switch and Battery Switch for Portable



PowerPAK SC-70-6 Dual



P-Channel MOSFET P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 12	v		
Gate-Source Voltage	V <sub>GS</sub>	± 8			
	$T_C = 25 ^{\circ}C$ $T_C = 70 ^{\circ}C$	_	- 4.5 <sup>a</sup> - 4.5 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 4.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 3.4 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	- 10		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	- 4.5 <sup>a</sup>		
Communication Brain Bload Carrent	T <sub>A</sub> = 25 °C	.5	- 1.6 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		6.5		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	5	W	
	T <sub>A</sub> = 25 °C	LD	1.9 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		1.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260	7 ~		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	$R_{thJA}$	52	65	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	12.5	16		

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under Steady State conditions is 110 °C/W.

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SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static		V 0.V I 050 vA		1	I	T ,,		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 12			V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$ $\Delta V_{GS(th)}/T_{J}$	I <sub>D</sub> = - 250 μA		- 7		mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient		,		2.1				
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA		
Zero Gate Voltage Drain Current	Inno	$V_{DS} = -12 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μА		
	I <sub>DSS</sub>	$V_{DS}$ = - 12 V, $V_{GS}$ = 0 V, $T_J$ = 55 °C			- 10			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 8			Α		
Drain-Source On-State Resistance <sup>a</sup>		$V_{GS} = -4.5 \text{ V}, I_D = -3.3 \text{ A}$		0.058	0.070	Ω		
	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 2.8 A		0.082	0.100			
		V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 0.7 A		0.111	0.140	1		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3.3 A		9		S		
Dynamic <sup>b</sup>					I			
Input Capacitance	C <sub>iss</sub>			400				
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		140		pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	23 / G5 /		100				
Treverse Harrister Supusitarios		V <sub>DS</sub> = - 6 V, V <sub>GS</sub> = - 8 V, I <sub>D</sub> = - 4.3 A		8	12	nC		
Total Gate Charge	Q <sub>g</sub> Q <sub>gs</sub> Q <sub>qd</sub>	V <sub>DS</sub> = -6 V, V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -4.3 A		5	7.5			
Gate-Source Charge				0.8	7.0			
Gate-Drain Charge		1 D3		1.4				
Gate Resistance	R <sub>g</sub>	f = 1 MHz		7		Ω		
Turn-On Delay Time	t <sub>d(on)</sub>	1 – 1 111112		15	25			
Rise Time	t <sub>r</sub>	$V_{DD} = -6 \text{ V}, R_L = 1.8 \Omega$ $I_D \cong -3.4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		25	40			
Turn-Off Delay Time				20	30			
Fall Time	t <sub>d(off)</sub>	.b = 0, vgeN 1,g						
Turn-On Delay Time	t <sub>f</sub>			10 5	15	ns		
	t <sub>d(on)</sub>	V 0VD 100			10	-		
Rise Time	t <sub>r</sub>	$V_{DD} = -6 \text{ V}, R_L = 1.8 \Omega$		12	20			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 3.4 A, $V_{GEN}$ = - 8 V, $R_g$ = 1 $\Omega$		20	30			
Fall Time	t <sub>f</sub>			10	15			
Drain-Source Body Diode Characterist		T 05.00		1	I	Γ		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 4.5	Α		
Pulse Diode Forward Current	I <sub>SM</sub>				10			
Body Diode Voltage	V <sub>SD</sub>	$I_S = -3.4 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.85	- 1.2	V		
Body Diode Reverse Recovery Time t <sub>rr</sub>				30	60	ns		
Body Diode Reverse Recovery Charge	$\frac{Q_{rr}}{t_a}$ I <sub>F</sub>	- I <sub>F</sub> = - 3.4 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		12	24	nC		
Reverse Recovery Fall Time				14		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			16				

### Notes:

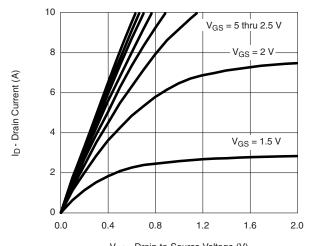
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



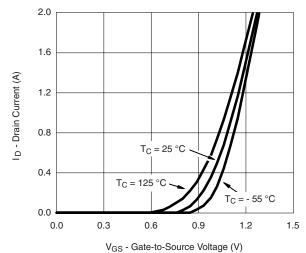
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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

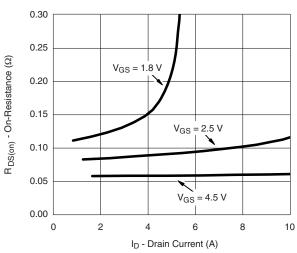


V<sub>DS</sub> - Drain-to-Source Voltage (V)

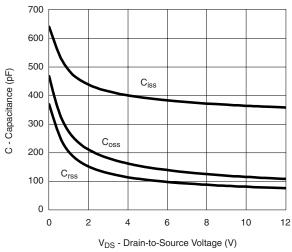
Output Characteristics



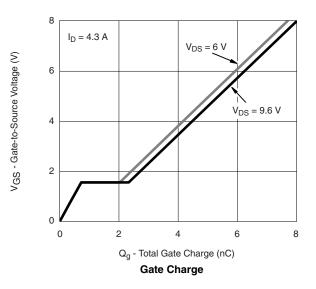
Transfer Characteristics

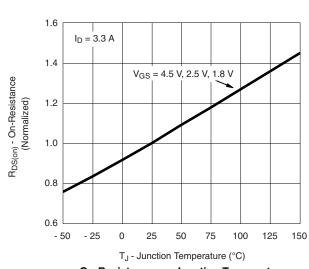


On-Resistance vs. Drain Current and Gate Voltage



Capacitance





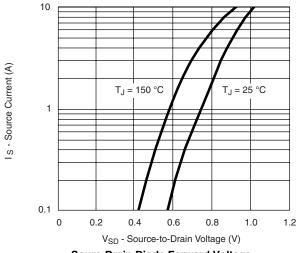
On-Resistance vs. Junction Temperature

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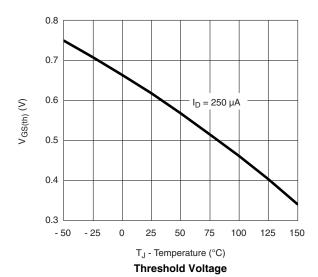
## Vishay Siliconix

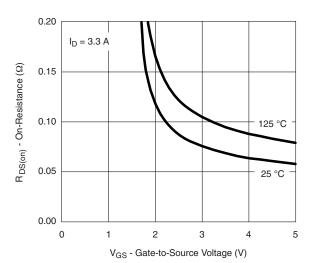
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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

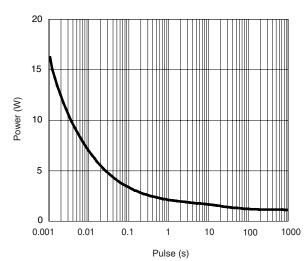


### Soure-Drain Diode Forward Voltage

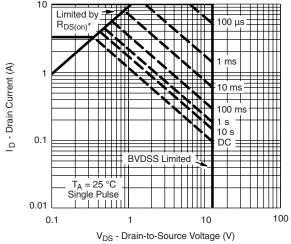




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

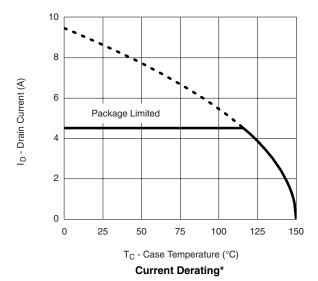
Power Dissipation (W)

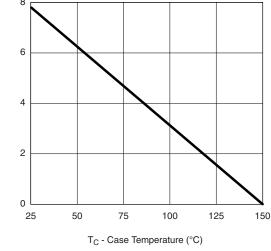




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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Power Derating

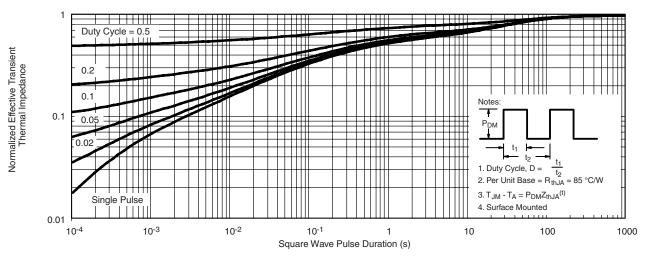
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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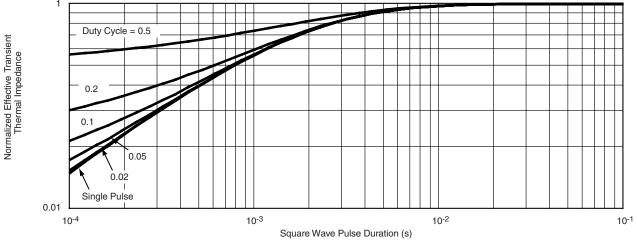
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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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